## STATS300A - Lecture 16

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11/15/21

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## 1 Recap

Our current goal is to find uniformally most powerful unbiased (UMPU) tests for testing  $H_0: \theta \in \Omega_0$  against  $H_1: \theta \in \Omega_1$ . Recall that a test function  $\phi$  is unbiased at level  $\alpha$  if

$$\mathbb{E}_{\theta_0} \phi \leq \alpha \text{ for all } \theta_0 \in \Omega_0,$$

and

$$\mathbb{E}_{\theta_1} \phi \geq \alpha \text{ for all } \theta_1 \in \Omega_1.$$

We also say a test  $\phi$  was  $\alpha$ -similar if for all  $\theta \in W$  where  $W = \overline{\Omega}_0 \cap \overline{\Omega}_1$ . We previously proved the following theorem which relates unbiased and  $\alpha$ -similar tests.

**Theorem 1** (TSH 4.11). If  $\theta \mapsto \mathbb{E}_{\theta} \phi$  is continuous for all tests  $\phi$  and  $\phi$  is uniformly most powerful among level  $\alpha$   $\alpha$ -similar tests, then  $\phi$  is UMPU at level  $\alpha$ .

Today we will find optimal unbiased tests in multiparameter exponential families. Specifically we will derive optimal one sided tests in the presence of nuisance parameters.

## 2 Multiparameter exponential families

Suppose we have a model  $\{P_{\theta,\lambda}\}$  where  $(\theta,\lambda) \in \mathbb{R}^{k+1}$  is unknown and  $P_{\theta,\lambda}$  has density

$$p_{\theta,\lambda}(x) = h(x) \exp\left\{\theta U(x) + \sum_{i=1}^{k} \lambda_i T_i(x) - A(\theta,\lambda)\right\}.$$

We wish to test  $H_0: \theta \leq \theta_0$  against  $H_1: \theta > \theta_0$ . For a fixed  $\theta$ , the family  $\{p_{\theta,\lambda}\}$  is an exponential family with sufficient statistics  $T = (T_1, \ldots, T_k)$  and so

$$P_{\theta,\lambda}(X|T) = P_{\theta}(X|T).$$

In particular we have  $P_{\theta,\lambda}(U(X)|T(X)) = P_{\theta}(U(X)|T(X))$  and so U(X)|T(X) has no  $\lambda$  dependence.

Remark 1. This observation is important. We have shown that conditioning eliminates the nuisance parameters. Thus we can fix  $(\theta_0, \lambda_0) \in \Omega_1$  and  $(\theta_1, \lambda_1)$  and construct a test based on  $P_{\theta_0}(X|T)$  against  $P_{\theta_1}(X|T)$  which has no  $\lambda$  dependence. Even better, conditioning on T gives us a one-dimensional exponential family.

**Lemma 1.** For each t, U(X)|T=t forms a one-dimensional exponetial family in  $\theta$ .

*Proof.* We will only consider the discrete case. For all u and t let

$$A_{u,t} = \{x \in \mathcal{X} : U(x) = u, T(x) = t\}$$
 and  $A_t = \{x \in \mathcal{X} : T(x) = t\}.$ 

$$\begin{split} P_{\theta,\lambda}(U(X) = u | T(X) = t) &= \frac{P_{\theta,\lambda}(U(X) = u, T(X) = t)}{P_{\theta,\lambda}(T(X) = t)} \\ &= \frac{\sum\limits_{x \in A_{u,t}} p_{\theta,\lambda}(x)}{\sum\limits_{x \in A_t} p_{\theta,\lambda}(x)} \\ &= \frac{\sum\limits_{x \in A_{u,t}} \exp\left\{\theta u + \sum_{i=1}^k \lambda_i t_i\right\} h(x)}{\sum\limits_{x \in A_t} \exp\left\{\theta U(x) + \sum_{i=1}^k \lambda_i t_i\right\} h(x)} \\ &= \underbrace{\exp\left\{\theta u\right\}}_{\text{exponential tilt}} \times \underbrace{\sum\limits_{x \in A_{u,t}} h(x)}_{g(t,u) = \text{base measure}} \times \underbrace{\frac{1}{\sum\limits_{x \in A_t} \exp\left\{\theta U(x)\right\} h(x)}_{c(t,\theta) = \text{normalizing constant}}}. \end{split}$$

So U(X)|T(X)=t is a one-dimensional exponential family with sufficient statistic U.

Thus we can apply our previously developed theory to the conditional distribution U|T. Our general recipe for one sided testing  $\theta \leq \theta_0$  against  $\theta > \theta_0$  is

- (1) Fix an alternative  $\theta = \theta_1 > \theta_0$  and  $\lambda_1 \in \mathbb{R}^k$ .
- (2) Condition on T so that X|T does not depend on  $\lambda$  and U|T follows a one dimensional exponential family.
- (3) Construct the MP test for the conditional distribution. That is

$$\phi_t(u) = \begin{cases} 1 & \text{if } u > k(t), \\ \rho(t) & \text{if } u = k(t), \\ 0 & \text{if } u < k(t). \end{cases}$$

where k(t) and  $\rho(t)$  are determined by the conditional level constraint

$$\mathbb{E}_{\theta_0}[\phi_t|T=t] = \alpha. \tag{1}$$

We will next argue that under some assumptions that test  $\phi^*(u,t) = \phi_t(u)$  is the UMPU test for  $H_0$  against  $H_1$ . Note that for every test  $\phi$ 

$$\mathbb{E}_{\theta,\lambda}\phi = \mathbb{E}_{\theta,\lambda}\left[\mathbb{E}_{\theta,\lambda}[\phi|T]\right] = \mathbb{E}_{\theta,\lambda}\left[\mathbb{E}_{\theta}[\phi|T]\right].$$

In particular if  $\theta \leq \theta_0$ , then

$$\mathbb{E}_{\theta,\lambda}\phi^* = \mathbb{E}_{\theta,\lambda}\left[\mathbb{E}_{\theta}[\phi|T]\right] \leq \mathbb{E}_{\theta,\lambda}[\alpha] = \alpha,$$

and we have equality if  $\theta = \theta_0$ . Thus  $\phi^*$  is level  $\alpha$  and  $\alpha$ -similar.

By Neyman-Pearson, there is no test that satisfies the constraint (1) and has strictly large power that  $\phi^*$  for some fixed t and  $\theta_1 > \theta$ . Thus  $\phi^*$  is the most powerful test in the class of tests satisfying (1) for any fixed  $\theta_1 > \theta$ . Since  $\phi^*$  does not depend on  $\theta_1$ , the test  $\phi^*$  is in fact the UMP test among tests satisfying the constrain (1).

Recall that we are trying to show that  $\phi^*$  is the UMPU test.